

Search Notes

Application/Control No.

10/644,893

Examiner

Brian Young

Applicant(s)/Patent under
Reexamination

YUN ET AL.

Art Unit

2819

SEARCHED

Class	Subclass	Date	Examiner
341	155	1/31/2005	BY
//	137		BY
348	294		BY
	295		BY
	300		BY
	301		BY
	302		BY
	303		BY
	308		BY
257	222		BY
250	208.1		BY

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (jpo,epo,derwent) NPL (IEEE Inspect)	1/31/2005	BY